

# **MOSFET** – P-Channel, QFET®

-200 V, -11.5 A, 470 m $\Omega$ 

# **FQB12P20**

#### **General Description**

These P-Channel enhancement mode power field effect transistors are produced using onsemi's proprietary, planar stripe, DMOS

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switching DC/DC converters.

#### **Features**

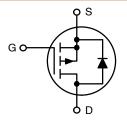
- -11.5 A, -200 V,  $R_{DS(on)} = 0.47 \Omega$  @  $V_{GS} = -10 \text{ V}$
- Low Gate Charge (Typical 31 nC)
- Low Crss (typical 30 pF)
- Fast Switching
- 100% Avalanche Tested
- Improved dv/dt Capability
- These Devices are Pb-Free and are RoHS Compliant

#### **MAXIMUM RATINGS** (T<sub>C</sub> = 25°C unless otherwise noted)

Symbol	Parameter	FQB12P20	Unit
V <sub>DSS</sub>	Drain-Source Voltage	-200	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°C)	-11.5	Α
	<ul><li>− Continuous (T<sub>C</sub> = 100°C)</li></ul>	-7.27	Α
I <sub>DM</sub>	Drain Current - Pulsed (Note 1)	-46	Α
V <sub>GSS</sub>	Gate-Source Voltage	+30	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)	810	mJ
I <sub>AR</sub>	Avalanche Current (Note 1)	-11.5	Α
E <sub>AR</sub>	Repetitive Avalanche Energy (Note 1)	12	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	-5.5	V/ns
$P_{D}$	Power Dissipation (T <sub>A</sub> = 25°C) *	3.13	W
	Power Dissipation (T <sub>C</sub> = 25°C)	120	W
	− Derate above 25°C	0.96	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range	-55 to +150	°C
T <sub>L</sub>	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

V <sub>DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX	
-200 V	0.47 Ω @ –10 V	–11.5 A	

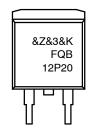


**P-CHANNEL MOSFET** 



D<sup>2</sup>PAK-3 (TO-263, 3-LEAD) CASE 418AJ

#### MARKING DIAGRAM



FQB12P20 = Specific Device Code &Z = Assembly Plant Code = Digit Date Code &3

= Lot Run Traceability Code &K

#### ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

<sup>\*</sup>When mounted on the minimum pad size recommended (PCB Mount) 1. Repetitive Rating: Pulse width limited by maximum junction temperature

<sup>2.</sup> L = 9.2 mH, I<sub>AS</sub> = -11.5 A, V<sub>DD</sub> = -50 V, R<sub>G</sub> = 25  $\Omega$ , Starting T<sub>J</sub> =  $25^{\circ}$ C 3. I<sub>SD</sub>  $\leq$  -11.5 A, di/dt  $\leq$  300 A/ $\mu$ s, V<sub>DD</sub>  $\leq$  BV<sub>DSS</sub>, Starting T<sub>J</sub> =  $25^{\circ}$ C

#### THERMAL RESISTANCE MAXIMUM RATINGS

Symbol	Parameter	Тур	Max	Unit
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case	-	1.04	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *	-	40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	-	62.5	°C/W

<sup>\*</sup>When mounted on the minimum pad size recommended (PCB Mount)

### **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25°C unless otherwise specified)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit	
OFF CHARACTERISTICS							
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-200	_	-	V	
$\Delta BV_{DSS} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = -250 μA, Referenced to 25°C	1	-	-	V/°C	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = -200 V, V <sub>GS</sub> = 0 V	-	_	-1	μΑ	
		V <sub>DS</sub> = -160 V, T <sub>C</sub> = 125°C	-	-	-10	μΑ	
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	-100	nA	
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V	ı	-	100	nA	
ON CHARAC	TERISTICS						
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = -250 \mu A$	-3.0	_	-5.0	V	
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	$V_{GS} = -10 \text{ V}, I_D = -5.75 \text{ A}$	-	0.36	0.47	Ω	
9FS	Forward Transconductance	V <sub>DS</sub> = -40 V, I <sub>D</sub> = -5.75 A (Note 4)	-	6.4	-	S	
DYNAMIC CH	IARACTERISTICS						
C <sub>iss</sub>	Input Capacitance	$V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$	-	920	1200	pF	
C <sub>oss</sub>	Output Capacitance		-	190	250	pF	
C <sub>rss</sub>	Reverse Transfer Capacitance		-	30	40	pF	
SWITCHING	CHARACTERISTICS			•	•		
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = -100 \text{ V}, I_D = -11.5 \text{ A},$	_	20	50	ns	
t <sub>r</sub>	Turn-On Rise Time	$R_G = 25 \Omega$ (Note 4, 5)	_	195	400	ns	
t <sub>d(off)</sub>	Turn-Off Delay Time		1	40	90	ns	
t <sub>f</sub>	Turn-Off Fall Time		1	60	130	ns	
Qg	Total Gate Charge	$V_{DS} = -160 \text{ V}, I_D = -11.5 \text{ A},$	-	31	40	nC	
$Q_{gs}$	Gate-Source Charge	V <sub>GS</sub> = −10 V (Note 4, 5)	1	8.1	-	nC	
Qg <sub>d</sub>	Gate-Drain Charge		-	16	-	nC	
DRAIN-SOUI	RCE DIODE CHARACTERISTICS AND MAXII	MUMUM RATINGS					
I <sub>S</sub>	Maximum Continuous Drain-Source Diode Forward Current		-	_	-11.5	Α	
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode Forward Current		-	_	-46	Α	
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = -11.5 A	-	_	-5.0	V	
t <sub>rr</sub>	Reverse Recovery Time	$V_{GS} = 0 \text{ V, } I_S = -11.5 \text{ A,}$	-	180	-	ns	
Q <sub>rr</sub>	Reverse Recovery Charge	dl <sub>F</sub> / dt = 100 A/μs (Note 4)	-	1.44	-	μС	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Pulse Test: Pulse width  $\leq 300~\mu s$ , Duty cycle  $\leq 2\%$ 5. Essentially independent of operating temperature

#### **TYPICAL CHARACTERISTICS**

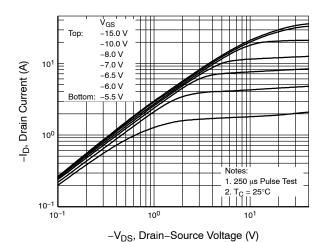


Figure 1. On Characteristics

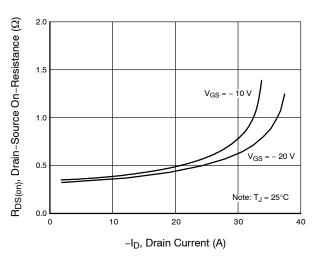


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

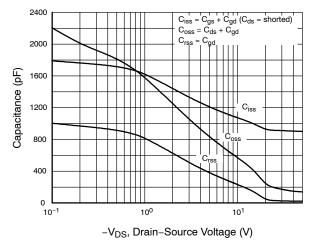


Figure 5. Capacitance Characteristics

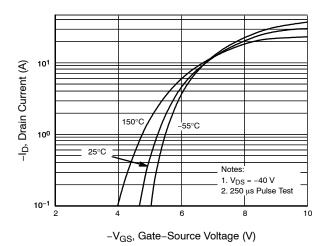


Figure 2. Transfer Characteristics

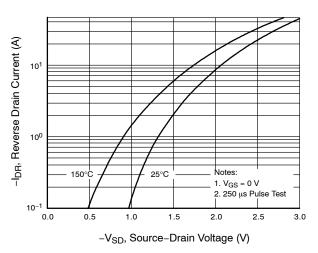


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

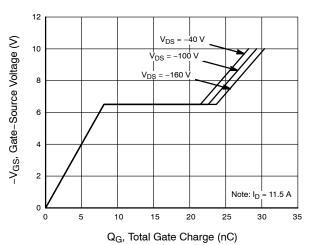


Figure 6. Gate Charge Characteristics

### TYPICAL CHARACTERISTICS (continued)

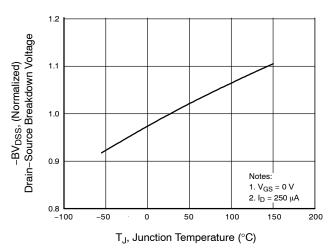


Figure 7. Breakdown Voltage Variation vs. Temperature

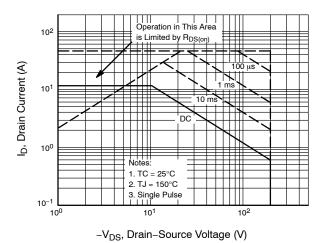
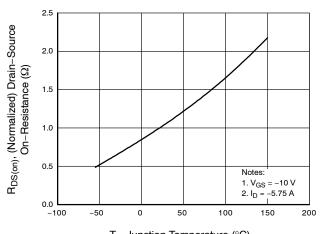


Figure 9. Maximum Safe Operating Area



T<sub>J</sub>, Junction Temperature (°C)

Figure 8. On-Resistance Variation vs. Temperature

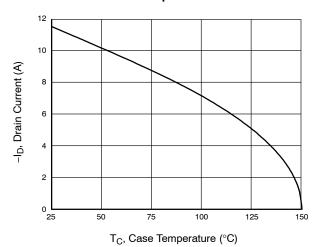
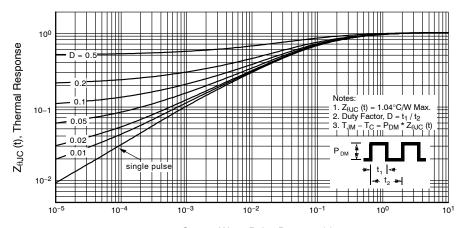


Figure 10. Maximum Drain Current vs.
Case Temperature



t<sub>1</sub>, Square Wave Pulse Duration (s)

Figure 11. Capacitance Characteristics

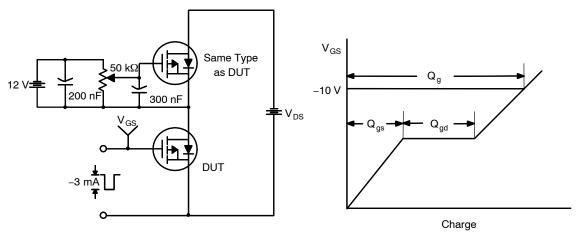


Figure 12. Gate Charge Test Circuit & Waveform

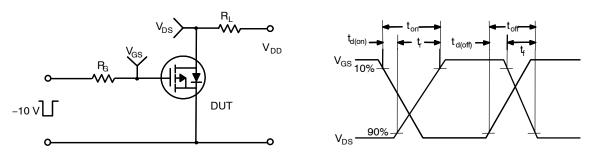


Figure 13. Resistive Switching Test Circuit & Waveforms

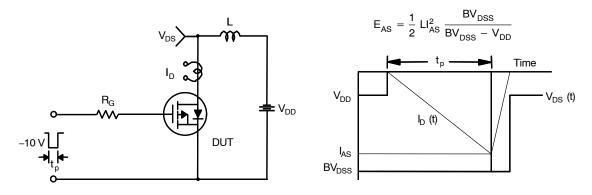
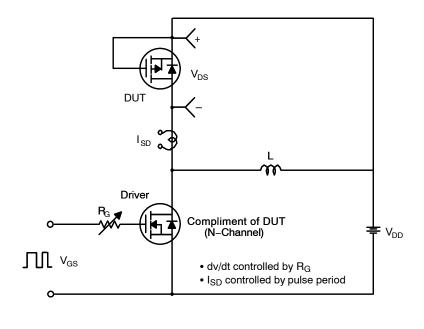


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



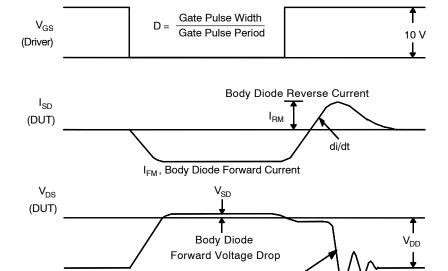


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

Body Diode Recovery dv/dt

### PACKAGE MARKING AND ORDERING INFORMATION

Device	Marking	Package	Reel Size	Tape Width	Shipping <sup>†</sup>
FQB12P20TM	FQB12P20	D <sup>2</sup> PAK (Pb-Free)	330 mm	24 mm	800 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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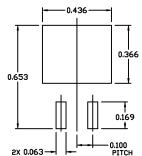




# D<sup>2</sup>PAK-3 (TO-263, 3-LEAD) CASE 418AJ

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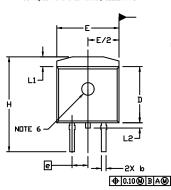


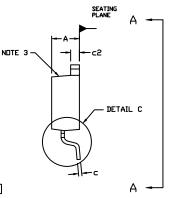
RECOMMENDED MOUNTING FOOTPRINT

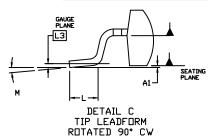
#### NOTES

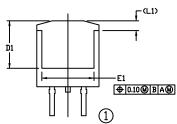
- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- CONTROLLING DIMENSION: INCHES
- CHAMFER OPTIONAL
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.005 PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE DUTERMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
- 5. THERMAL PAD CONTOUR IS OPTIONAL WITHIN DIMENSIONS E, L1, D1, AND E1.
- 6. OPTIONAL MOLD FEATURE.
- 7. ①,② ... OPTIONAL CONSTRUCTION FEATURE CALL DUTS.

	INCHES		MILLIMETERS	
DIM	MIN.	MAX.	MIN.	MAX.
A	0.160	0.190	4.06	4.83
A1	0.000	0.010	0.00	0.25
ھ	0.020	0.039	0.51	0.99
u	0.012	0.029	0.30	0.74
5	0.045	0.065	1.14	1.65
D	0.330	0.380	8.38	9.65
D1	0.260		6.60	
E	0.380	0.420	9.65	10.67
E1	0.245	-	6.22	
e	0.100 BSC		2.54 BSC	
Ξ	0.575	0.625	14.60	15.88
٦	0.070	0.110	1.78	2.79
L1		0.066		1.68
L2		0.070		1.78
L3	0.010 BSC		0.25 BSC	
М	0*	8*	0*	8*

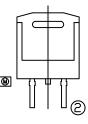


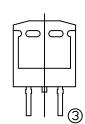


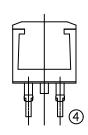




VIEW A-A







VIEW A-A OPTIONAL CONSTRUCTIONS

AYWW

XXXXXXXXX

Rectifier

**AKA** 

**GENERIC MARKING DIAGRAMS\*** 

XXXXXX

**XXYMW** 

SSG

XXXXXX = Specific Device Code = Assembly Location Α

WL = Wafer Lot

= Year ww = Work Week

W = Week Code (SSG) Μ = Month Code (SSG)

G = Pb-Free Package = Polarity Indicator **AKA** 

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ", may or may not be present. Some products may not follow the Generic Marking.

# IC

XXXXXXXX

**AWLYWWG** 

98AON56370E

Standard

XXXXXXXX

**AYWW** 

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